


<b>Search Notes</b>  	<b>Application/Control No.</b>  10789986	<b>Applicant(s)/Patent Under Reexamination</b>  HAYASHI, JUNICHI
	<b>Examiner</b>  Shan, April Y	<b>Art Unit</b>  2135

SEARCHED			
Class	Subclass	Date	Examiner
380	210	1/18/2008	AS
	54	1/18/2008	AS
	287	1/18/2008	AS
283	17	1/18/2008	AS
	73	1/18/2008	AS

SEARCH NOTES		
Search Notes	Date	Examiner
Text search on EAST	1/18/2008	AS
713/161; 382/232 (Limit by text on EAST, see notes)	1/18/2008	AS
Consult with Primary Examiner (Song Ho) on allowable subject matter	1/16/2008	AS
Double patenting search on EAST, inventor name search	1/18/2008	AS
NPL search (ACM search)	1/18/2008	AS

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
	See EAST notes labeled "Interference Search Notes"	1/18/2008	AS